

Notice of References Cited	Application/Control No. 10/801,718	Applicant(s)/Patent Under Reexamination HIRAIWA ET AL.	
	Examiner Daniel Kim	Art Unit 2185	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0010733	01-2005	Mimatsu et al.	711/162
*	B	US-2004/0039890	02-2004	Itoh et al.	711/162
*	C	US-2003/0200275	10-2003	Hirabayashi et al.	709/214
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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